TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TC74VHC132F, TC74VHC132FN, TC74VHC132FT

QUAD 2-INPUT SCHMITT NAND GATE

The TC74VHC132 is an advanced high speed CMOS 2-INPUT SCHMITT NAND GATE fabricated with silicon gate C2MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

Pin configuration and function are the same as the TC74VHC00 but the inputs have hysteresis and with its schmitt trigger function, the TC74VHC132 can be used as a line receivers which will receive slow input signals.

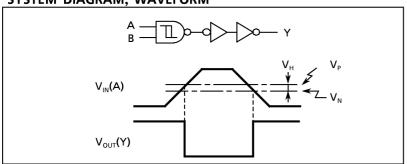
An input protection circuit ensures that 0 to 5.5V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5V to 3V systems and two supply systems such as battery back up.

This circuit prevents device destruction due to mismatched supply and input voltages.

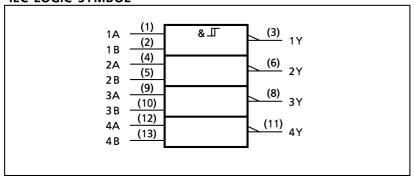
FEATURES:

- High Speed······ $t_{pd} = 4.9 \text{ns}(typ.)$ at $V_{CC} = 5V$
- Low Power Dissipation············ $I_{CC} = 2\mu A(Max.)$ at Ta = 25°C
- Power Down Protection is provided on all inputs.
- Balanced Propagation Delays..... $t_{pLH} \simeq t_{pHL}$
- Wide Operating Voltage Range····V_{CC} (opr) = 2V~5.5V
- Pin and Function Compatible with 74ALS132

SYSTEM DIAGRAM, WAVEFORM

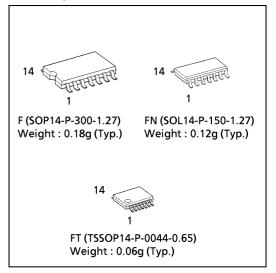


IEC LOGIC SYMBOL

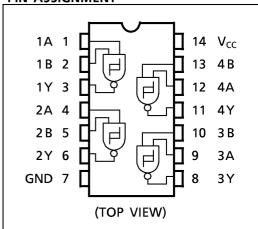


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(Note) The JEDEC SOP (FN) is not available in Japan.



PIN ASSIGNMENT



TRUTH TABLE

Α	В	Υ
L	L	Н
L	Н	Н
Н	L	Н
Н	Н	L

ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	V_{CC}	-0.5~7.0	V
DC Input Voltage	VIN	-0.5~7.0	V
DC Output Voltage	V _{OUT}	$-0.5 \sim V_{CC} + 0.5$	٧
Input Diode Current	I _{IK}	-20	mA
Output Diode Current	I _{OK}	± 20	mA
DC Output Current	I _{OUT}	± 25	mA
DC V _{CC} /Ground Current	I _{CC}	± 50	mA
Power Dissipation	P _D	180	mW
Storage Temperature	T _{stg}	−65~150	°C

RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	V _{cc}	2.0~5.5	V
Input Voltage	VIN	0~5.5	V
Output Voltage	V _{OUT}	0~V _{cc}	V
Operating Temperature	Topr	−40~85	°C

DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION		V _{cc}	Ta = 25°C		C	Ta = −40~85°C		UNIT
TANAMIETER STIMBO		TEST CONDITION			MIN.	TYP.	MAX.	MIN.	MAX.	
Positive Threshold Voltage	V _P				111	111	2.20 3.15 3.85	_ _ _	2.20 3.15 3.85	٧
Negative Threshold Voltage	V _N		3.0 4.5 5.5	0.90 1.35 1.65	111		0.90 1.35 1.65		V	
Hysteresis Output Voltage	V _H			3.0 4.5 5.5	0.30 0.40 0.50	111	1.20 1.40 1.60	0.30 0.40 0.50	1.20 1.40 1.60	V
High - Level Output Voltage	V _{OH}	V _{IN} = V _{IH} or V _{IL}	$I_{OH} = -50\mu A$	2.0 3.0 4.5	1.9 2.9 4.4	2.0 3.0 4.5		1.9 2.9 4.4		>
Output Voltage			$I_{OH} = -4mA$ $I_{OH} = -8mA$	3.0 4.5	2.58 3.94	1 1		2.48 3.80	-	
Low - Level Output Voltage	V _{OL}	$V_{IN} = V_{IH}$	I _{OL} = 50μA	2.0 3.0 4.5	111	0.0 0.0 0.0	0.1 0.1 0.1	_ _ _	0.1 0.1 0.1	>
			$I_{OL} = 4mA$ $I_{OL} = 8mA$	3.0 4.5	1 1	1 1	0.36 0.36	_	0.44 0.44	
Input Leakage Current	I _{IN}	V _{IN} = 5.5V or GND		0~5.5	-	-	±0.1	_	± 1.0	
Quiescent Supply Current	I _{CC}	$V_{IN} = V_{CC}$	$V_{IN} = V_{CC}$ or GND			_	2.0	_	20.0	μ A

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AC ELEC	TRICAL	CHARACTERISTICS	(In	put t	r = t	_f = 3ns))
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PARAMETER	CYMPOL	TES	TEST CONDITION		Ta = 25°C			Ta = - 40~85°C		UNIT
PARAIVIETER	SYMBOL		V _{CC} (V)	CL (pF)	MIN.	TYP.	MAX.	MIN.	MAX.	UIVII
Propagation Delay Time	t _{pLH} t _{pHL}		3.3 ± 0.3	15	_	7.6	11.9	1.0	14.0	ns
			3.3 ± 0.3	50	_	10.1	15.4	1.0	17.5	
			5.0 ± 0.5	15	_	4.9	7.7	1.0	9.0	113
			3.0 ± 0.5	50	_	6.4	9.7	1.0	11.0	
Input Capacitance	C _{I N}	·			_	4	10	_	10	-
Power Dissipation Capacitance	C _{PD}		(Note 1)		_	16	_	_	_	pF

Note (1) C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

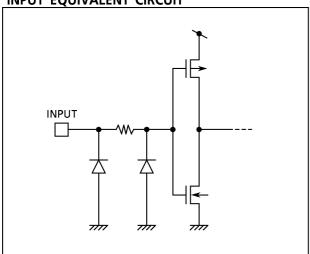
Average operating current can be obtained by the equation:

 $\hat{I}_{CC \text{ (opr.)}} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC} / 4 \text{ (per Gate.)}$

NOISE CHARACTERISTICS (Input $t_r = t_f = 3ns$)

PARAMETER	CVMDOL	TEST CONDIT	Ta =	UNIT		
FARAIVIETER	SYMBOL		V _{CC} (V)	TYP.	MAX.	OIVII
Quiet Output Maximum Dynamic V _{OL}	V _{OLP}	$C_L = 50pF$	5.0	0.3	0.8	>
Quiet Output Minimum Dynamic V _{OL}	V _{OLV}	$C_L = 50pF$	5.0	-0.3	-0.8	>
Minimum High Level Dynamic Input Voltage	V _{IHD}	$C_L = 50pF$	5.0	-	3.5	>
Maximum Low Level Dynamic Input Voltage	V _{ILD}	C _L = 50pF	5.0	-	1.5	٧

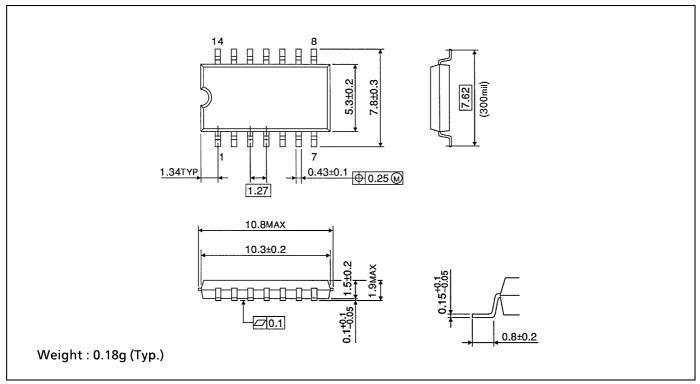
INPUT EQUIVALENT CIRCUIT



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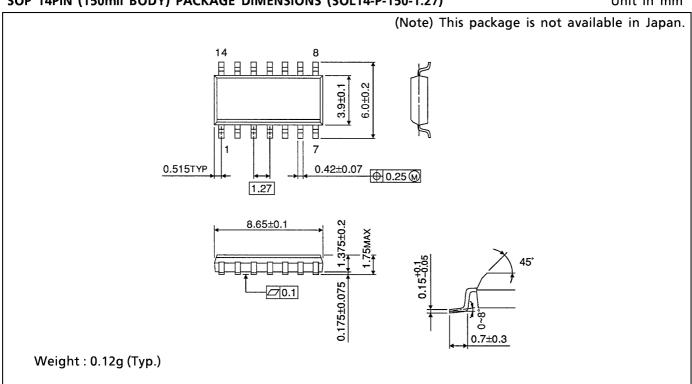
SOP 14PIN (200mil BODY) PACKAGE DIMENSIONS (SOP14-P-300-1.27)

Unit in mm



SOP 14PIN (150mil BODY) PACKAGE DIMENSIONS (SOL14-P-150-1.27)

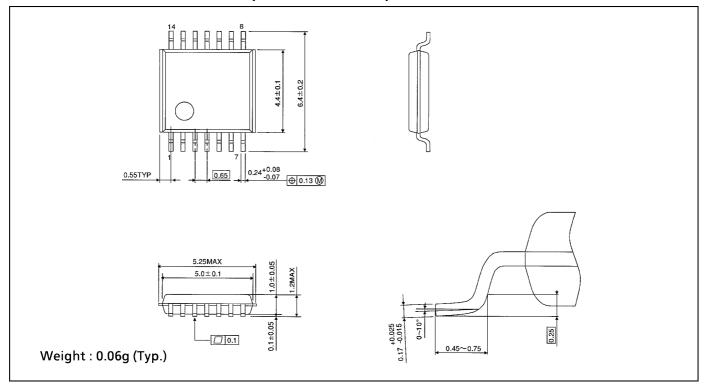
Unit in mm



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TSSOP 14PIN PACKAGE DIMENSIONS (TSSOP14-P-0044-0.65)

Unit in mm



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